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SEMICONDUCTOR®

### February 2008

## FDMS8670S N-Channel PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30V, 42A, 3.5mΩ

#### Features

- Max  $r_{DS(on)} = 3.5 m\Omega$  at  $V_{GS} = 10V$ ,  $I_D = 20A$
- Max  $r_{DS(on)} = 5.0 m\Omega$  at  $V_{GS} = 4.5 V$ ,  $I_D = 17 A$
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- RoHS Compliant

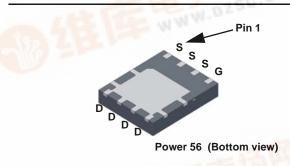


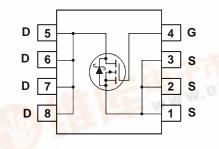
## **General Description**

The FDMS8670S has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

## Application

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification





## MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	$T_C = 25^{\circ}C$		42		
	-Continuous (Silicon limited)	$T_C = 25^{\circ}C$		116		
I <sub>D</sub>	-Continuous (Silicon limited) T <sub>C</sub> = 100°C		120 500	74	A	
	-Continuous	T <sub>A</sub> = 25°C	11111	20		
	-Pulsed	1212		200		
	Power Dissipation	$T_{C} = 25^{\circ}C$		78		
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25°C	(Note 1a)	2.5	W	
	Power Dissipation	$T_A = 85^{\circ}C$	(Note 1a)	1.3		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	
Thermal Ch	naracteristics				·	
Reic	Thermal Resistance. Junction to Case			1.6		

R <sub>0JC</sub>	Thermal Resistance, Junction to Case	1.6	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/vv

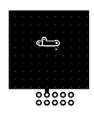
#### Package Marking and Ordering Information

t	PDevice Marking	Device	Package	Reel Size	Tape Width	Quantity
11		FDMS8670S	Power 56	13"	12mm	3000 units

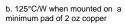
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 1mA$ , $V_{GS} = 0V$	30			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10$ mA, referenced to 25°C		17		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24V, V_{GS} = 0V$			500	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA	
On Chara	cteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1mA$	1	1.5	3	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 50$ mA, referenced to 25°C		-2.8		mV/°C	
	Drain to Source On Resistance	$V_{GS} = 10V, I_D = 20A$		2.8	3.5		
r <sub>DS(on)</sub>		$V_{GS} = 4.5V, I_D = 17A$		3.6	5.0	mΩ	
		$V_{GS} = 10V, I_D = 20A, T_J = 125^{\circ}C$		3.9	6.0		
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10V, I_{D} = 20A$		98		S	
Dvnamic	Characteristics						
C <sub>iss</sub>	Input Capacitance			3005	4000	pF	
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 0V f = 1MHz		865	1150	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			320	480	pF	
R <sub>q</sub>	Gate Resistance	f = 1MHz		1.4	5.0	Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			14	26	ns	
t <sub>r</sub>	Rise Time	$V_{DD} = 15V, I_D = 20A$		19	35	ns	
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 5\Omega$		37	60	ns	
t <sub>f</sub>	Fall Time			10	20	ns	
Q <sub>g(TOT)</sub>	Total Gate Charge at 10V	$V_{GS} = 0V$ to 10V		52	73	nC	
Q <sub>g(4.5V)</sub>	Total Gate Charge at 4.5V	$V_{GS} = 0V \text{ to } 4.5V$ $V_{DS} = 15V$		24	34	nC	
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 20A		8		nC	
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			10		nC	

V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 2A$
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 20A, di/dt = 300A/μs
Q <sub>rr</sub>	Reverse Recovery Charge	$F = 20A$ , ui/ul = $300A/\mu s$

Notes:
 1: R<sub>θJA</sub> is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R<sub>θJC</sub> is guaranteed by design while R<sub>θCA</sub> is determined by the user's board design.



a. 50°C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



26

24

42

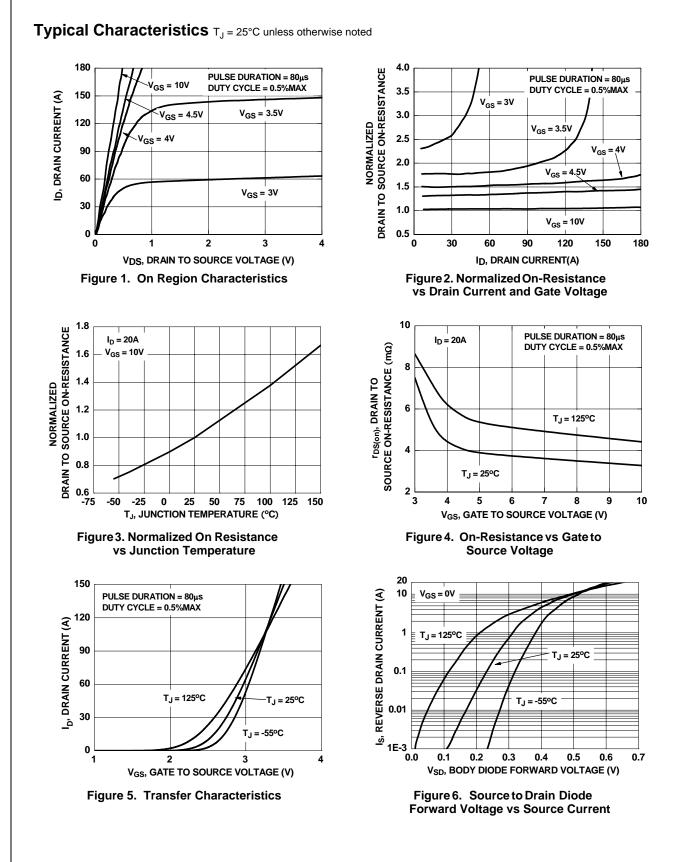
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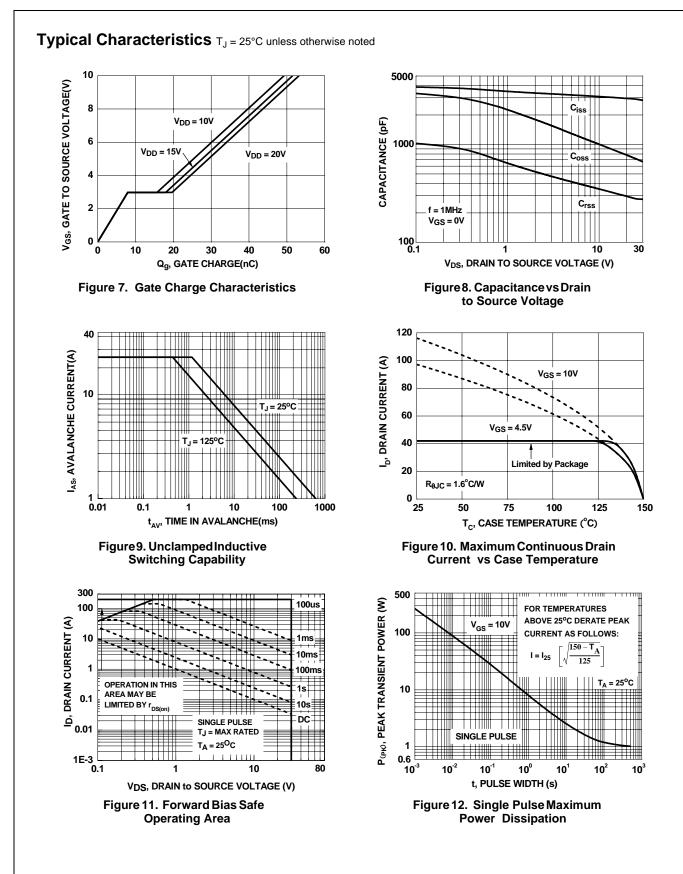
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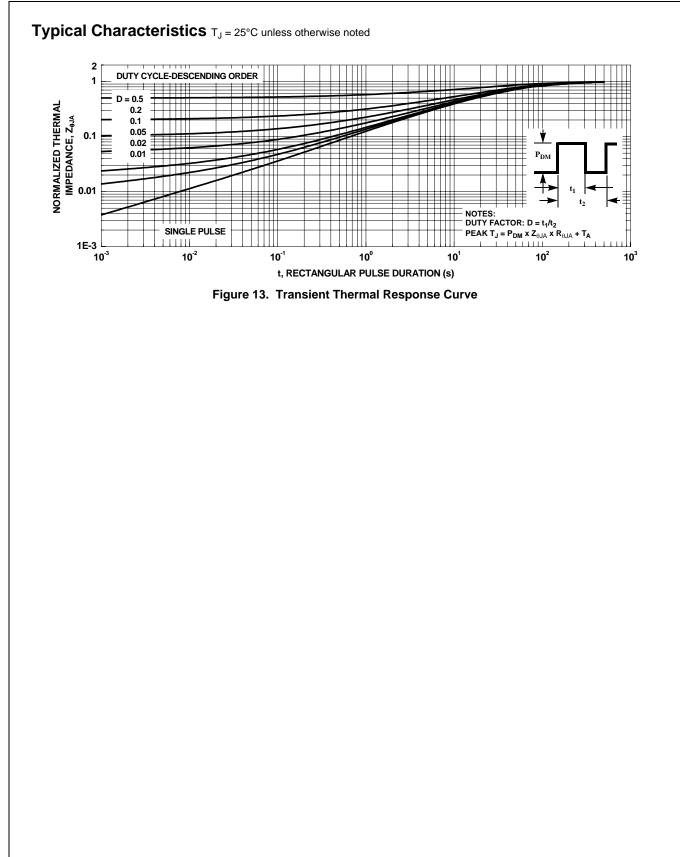
nC



2: Pulse time <  $300\mu$ s, Duty cycle < 2%.



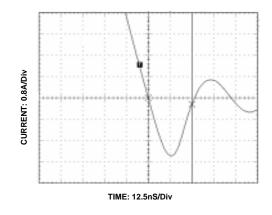


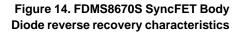


## Typical Characteristics (continued)

#### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS8670S.





Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

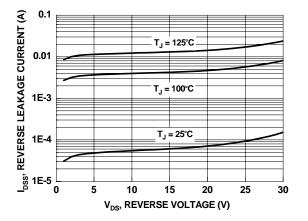


Figure 15. SyncFET Body Diode reverse leakage vs drain to source voltage

A 5.00 3.91 -1.27 PKG ¢ В 7 8 6 5 8 5 0.77 4.52 РКGĘ 6.00 6.61  $\mathcal{Q}$ 1.27 PIN #1 INDICATOR 4 1 1 TOP VIEW 2 3 1 4 1.27 -0.61 -1.05 // 0.10 C 3.81 0.06 ⊇|0.08|C LAND PATTERN C RECOMMENDATION SIDE VIEW 3.81-1.27 0.46 0.36 (0.39)⊕ 0.10M C A B 3 2 4 0.64 (0.35)PIN #1 IDENT 4.01±0.30 (OPTIONAL) 1.81 €<sup>0.64</sup> 5 8 7 6 3.86 3.66 BOTTOM VIEW NOTES: UNLESS OTHERWISE SPECIFIED A) ALL DIMENSIONS ARE IN MILLIMETERS. NO JEDEC REFERENCE AS OF FEBRUARY 2006 B) DIMENSIONING AND TOLERANCING PER ASME Y14.5M 1994 C) PQFN08AREVA

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